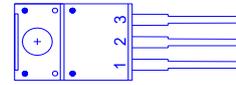
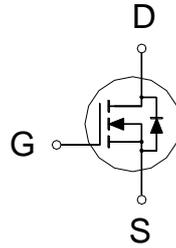


PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
150V	15m Ω	35A



1: GATE
2: DRAIN
3: SOURCE



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	150	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	35	A
	$T_C = 100^\circ\text{C}$		22	
Pulsed Drain Current ¹		I_{DM}	123	
Avalanche Current		I_{AS}	18	
Avalanche Energy	$L = 1\text{mH}$	E_{AS}	162	mJ
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	40	W
	$T_C = 100^\circ\text{C}$		16	
Junction & Storage Temperature Range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient	$R_{\theta JA}$		62.5	$^\circ\text{C} / \text{W}$
Junction-to-Case	$R_{\theta JC}$		3.1	

¹Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

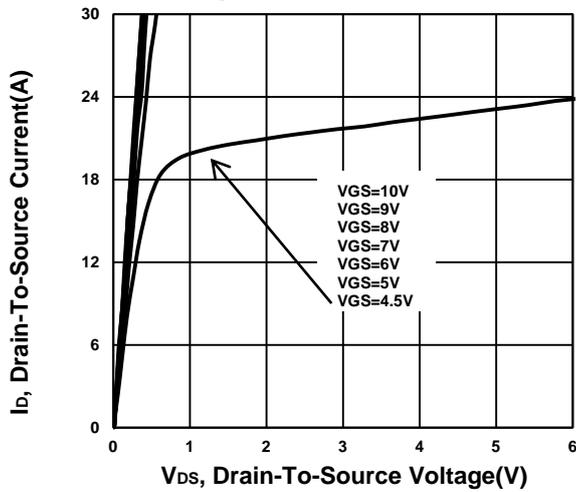
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	150			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	2.9	4	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 150\text{V}, V_{GS} = 0\text{V}$			1	μA
		$V_{DS} = 120\text{V}, V_{GS} = 0\text{V}, T_J = 55^\circ\text{C}$			10	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = 10\text{V}, I_D = 20\text{A}$		11	15	m Ω

Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 20A$		53		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 75V, f = 1MHz$		2593		pF
Output Capacitance	C_{oss}			244		
Reverse Transfer Capacitance	C_{rss}			7.6		
Total Gate Charge ²	Q_g	$V_{GS} = 10V, V_{DS} = 75V$ $I_D = 20A$		38		nC
Gate-Source Charge ²	Q_{gs}			11		
Gate-Drain Charge ²	Q_{gd}			9.1		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DS} = 75V,$ $I_D \cong 20A, V_{GS} = 10V, R_{GEN} = 6\Omega$		16		nS
Rise Time ²	t_r			47		
Turn-Off Delay Time ²	$t_{d(off)}$			34		
Fall Time ²	t_f			58		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ C$)						
Continuous Current	I_S				33	A
Forward Voltage ¹	V_{SD}	$I_F = 20A, V_{GS} = 0V$			1.2	V
Diode Reverse Recovery Time	t_{rr}	$I_F = 20A, di/dt = 100A/\mu s$			87	nS
Diode Reverse Recovery Charge	Q_{rr}					164

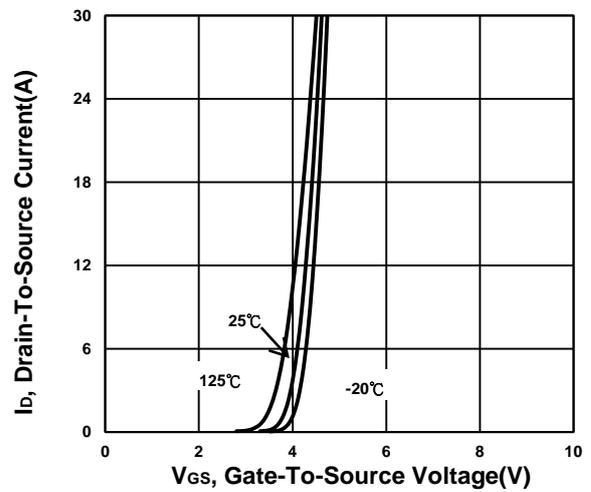
¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

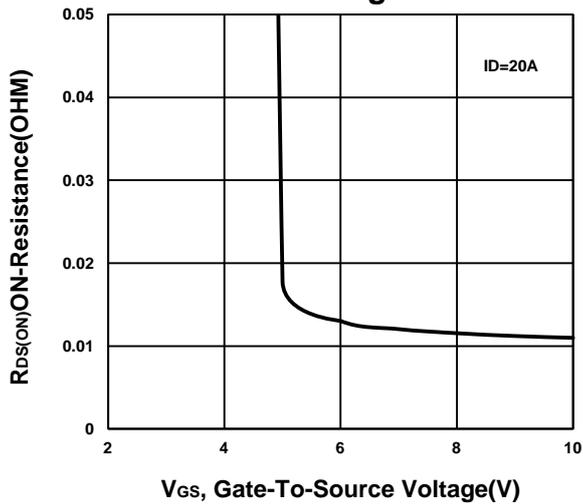
Output Characteristics



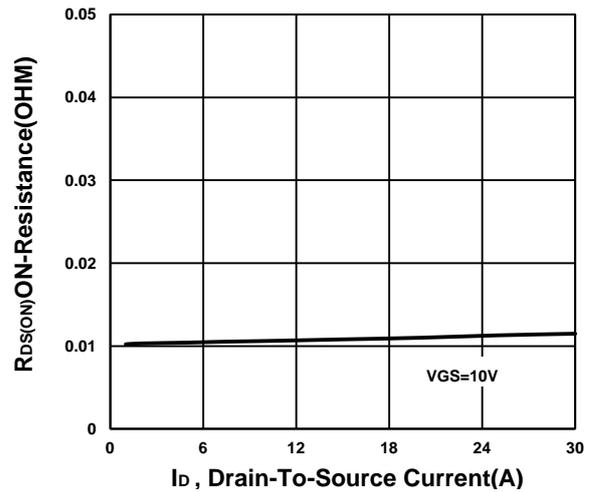
Transfer Characteristics



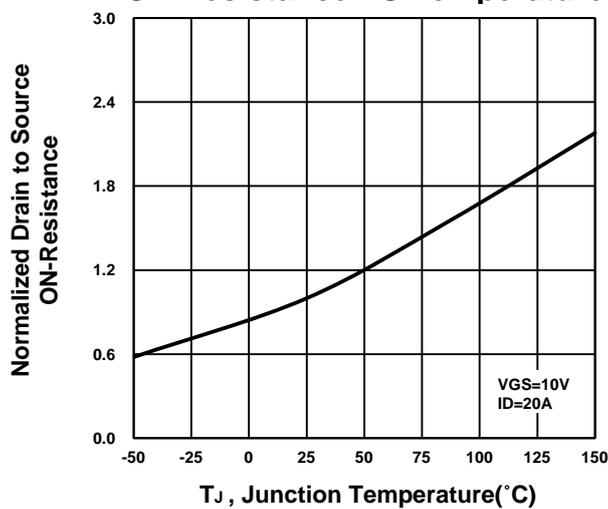
On-Resistance VS Gate-To-Source Voltage



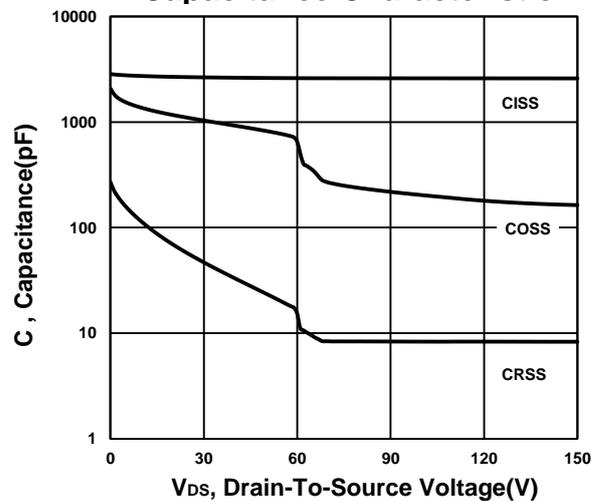
On-Resistance VS Drain Current



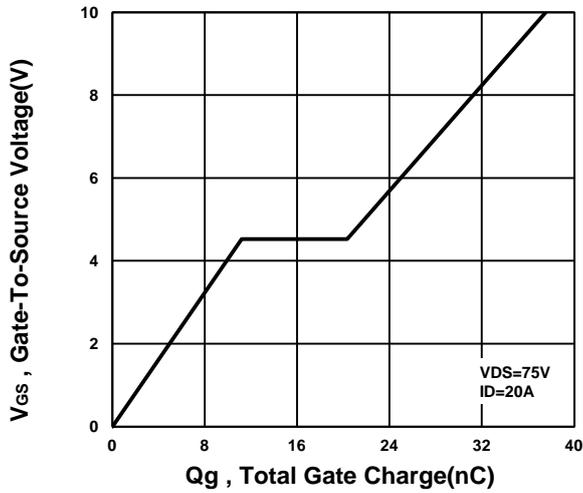
On-Resistance VS Temperature



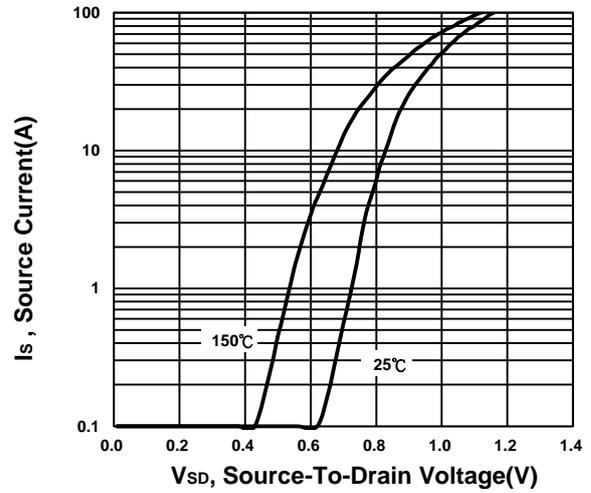
Capacitance Characteristic



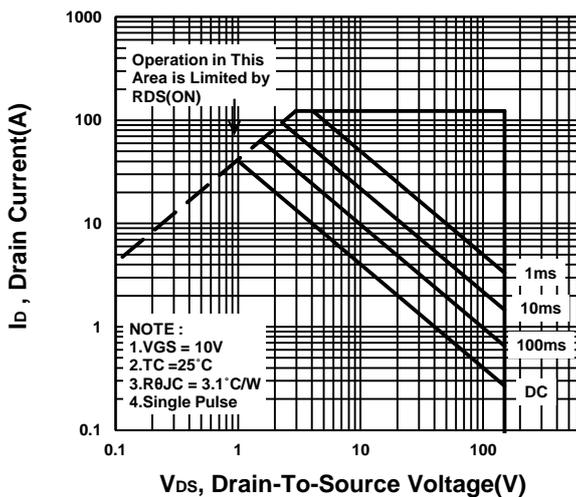
Gate charge Characteristics



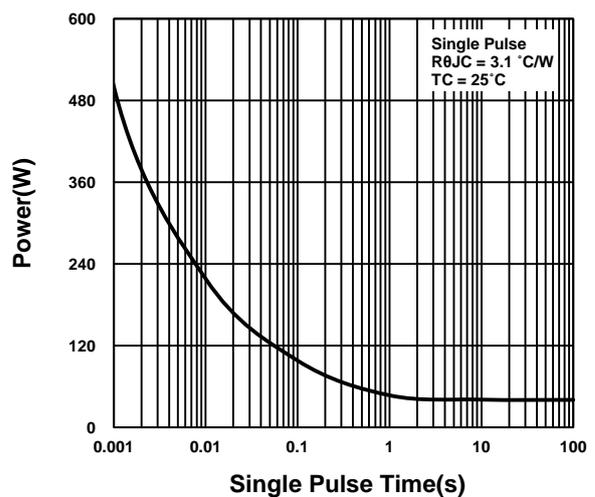
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

